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# HM658512AI Series

4 M PSRAM (512-kword × 8-bit)  
2 k Refresh

# HITACHI

ADE-203-286C(Z)  
Rev. 3.0  
March 15, 1999

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## Description

The Hitachi HM658512AI is a 4-Mbit pseudo static RAM organized 524288-word × 8-bit. It realizes higher density, higher performance and low power consumption by employing 0.8 μm Hi-CMOS process technology. It offers low power data retention by self refresh mode. HM658512AI is suitable for handy systems which work with battery back-up systems. It is packaged in 32-pin plastic SOP.

## Features

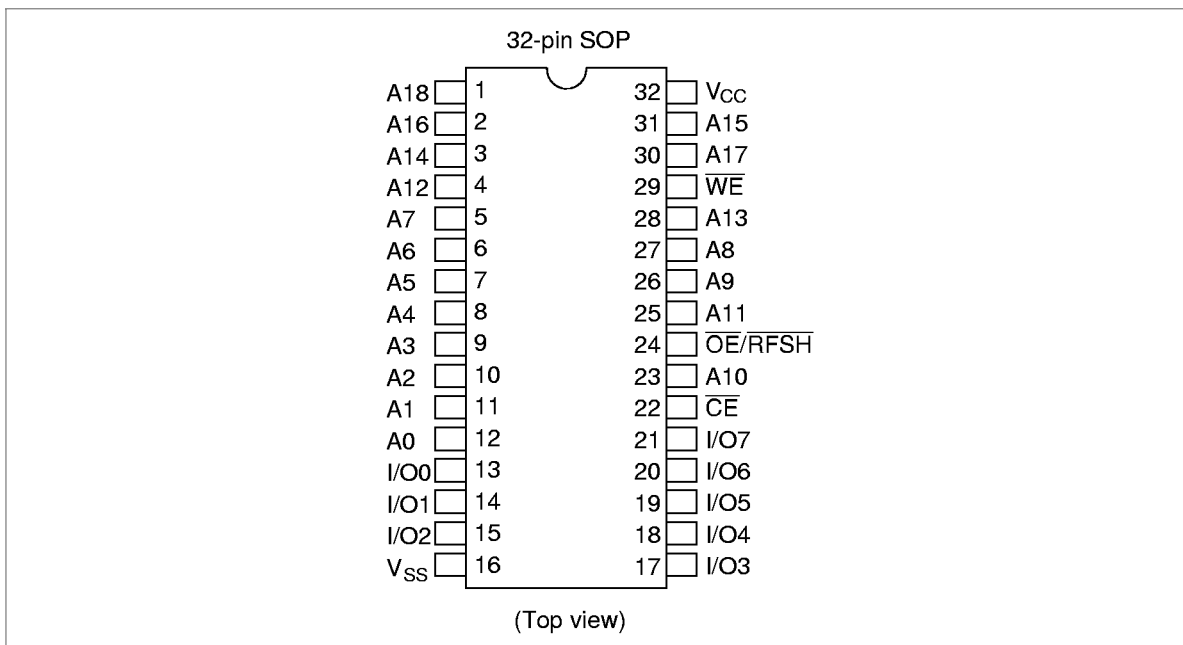
- Single 5 V supply: 5 V ±10%
- High speed
  - $\overline{CE}$  access time: 80 ns/100 ns/120 ns (max)
  - Random read/write cycle time: 130 ns/160 ns/190 ns (min)
- Power dissipation
  - Active: 250 mW (typ)
  - Standby: 350 μW (typ)
- Directly TTL compatible all inputs and outputs
- Simple address configuration
  - Non multiplexed address
- Refresh cycle
  - 2048 refresh cycles: 32 ms
- Easy refresh functions
  - Address refresh
  - Automatic refresh
  - Self refresh
- Temperature range: -40 to +85°C

## HM658512AI Series

### Ordering Information

Type No.	Access time	Package
HM658512ALFPI-8	80 ns	525-mil 32-pin plastic SOP (FP-32D)
HM658512ALFPI-10	100 ns	
HM658512ALFPI-12	120 ns	
HM658512ALFPI-8V	80 ns	
HM658512ALFPI-10V	100 ns	
HM658512ALFPI-12V	120 ns	

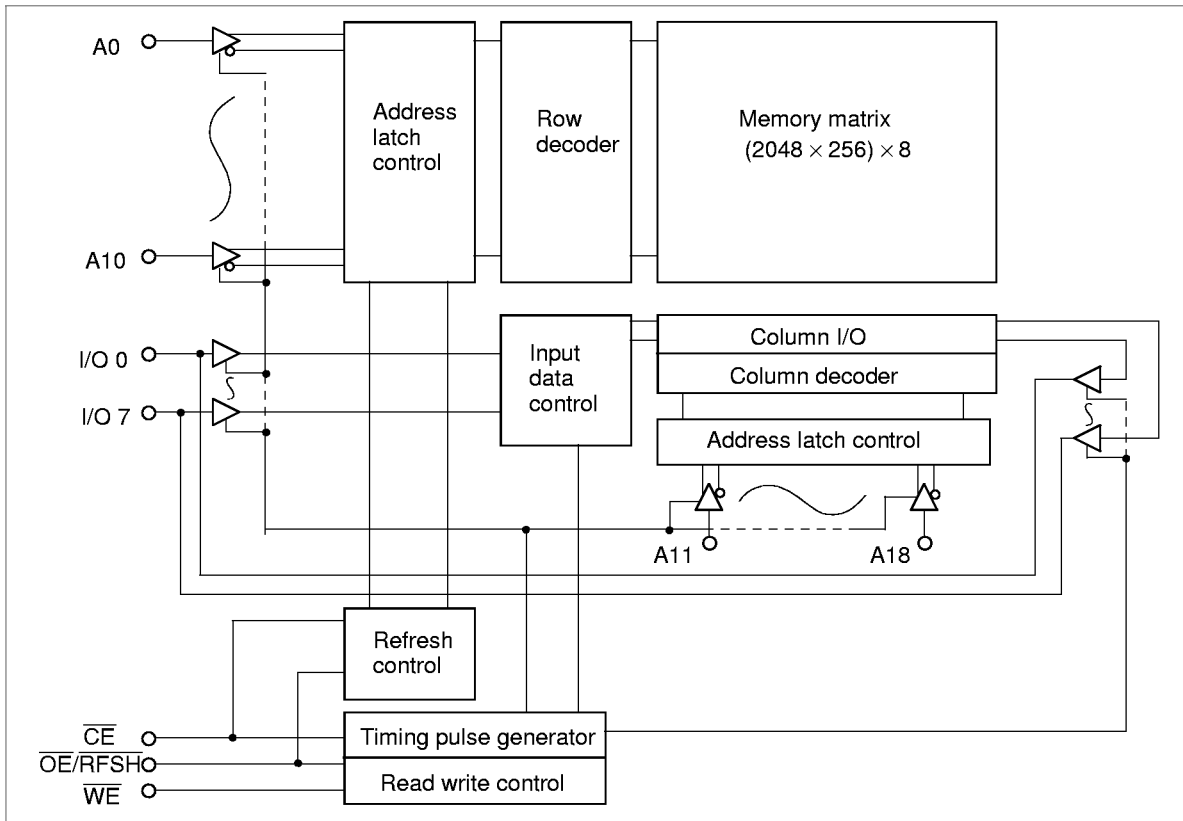
### Pin Arrangement



### Pin Description

Pin name	Function
A0 to A18	Address input
I/O0 to I/O7	Data input/output
$\overline{CE}$	Chip enable
$\overline{OE}/RFSH$	Output enable/Refresh
$\overline{WE}$	Write enable
V <sub>CC</sub>	Power supply
V <sub>SS</sub>	Ground

**Block Diagram**



**Pin Functions**

**$\overline{CE}$  (Input) :**  $\overline{CE}$  is a basic clock. RAM is active when  $\overline{CE}$  is low, and is on standby when  $\overline{CE}$  is high.

**A0 to A18 (Input):** A0 to A10 are row addresses and A11 to A18 are column addresses. The entire addresses A0 to A18 are fetched into RAM by the falling edge of  $\overline{CE}$ .

**$\overline{OE/RFSH}$  (Input) :** This pin has two functions. Basically it works as  $\overline{OE}$  when  $\overline{CE}$  is low, and as  $\overline{RFSH}$  when  $\overline{CE}$  is high (in standby mode). After a read or write cycle finishes, refresh does not start if  $\overline{CE}$  goes high while  $\overline{OE/RFSH}$  is held low. In order to start a refresh in standby mode,  $\overline{OE/RFSH}$  must go high to reset the refresh circuits of the RAM. After the refresh circuits are reset, the refresh starts when  $\overline{OE/RFSH}$  goes low.

**I/O0 to I/O7 (Inputs and Outputs) :** These pins are data I/O pins.

**$\overline{WE}$ (Input):** RAM is in write mode when  $\overline{WE}$  is low, and is in read mode when  $\overline{WE}$  is high. I/O data is fetched into RAM by the rising edge of  $\overline{WE}$  or  $\overline{CE}$  (earlier timing) and the data is written into memory cells.

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## HM658512AI Series

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### Notes

#### Refresh

There are three refresh modes : address refresh, automatic refresh and self refresh.

- (1) Address refresh: Data is refreshed by accessing all 2048 row addresses every 32 ms. A read is one method of accessing those addresses. Each row address (2048 addresses of A0 to A10) must be read at least once every 32 ms. In address refresh mode,  $\overline{\text{OE}}/\overline{\text{RFSH}}$  can remain high. In this case, the I/O pins remain at high impedance, but the refresh is done within RAM.
- (2) Automatic refresh: Instead of address refresh, automatic refresh can be used. RAM goes to automatic refresh mode if  $\overline{\text{OE}}/\overline{\text{RFSH}}$  falls while  $\overline{\text{CE}}$  is high and it remains low for at least  $t_{\text{FAP}}$ . One automatic refresh cycle is executed by one low pulse of  $\overline{\text{OE}}/\overline{\text{RFSH}}$ . It is not necessary to input the refresh address from outside since it is generated internally by an on-chip address counter. 2048 automatic refresh cycles must be done every 32 ms.
- (3) Self refresh: Self refresh mode is suitable for data retention by battery. In standby mode, a self refresh starts automatically when  $\overline{\text{OE}}/\overline{\text{RFSH}}$  stays low for more than 8  $\mu\text{s}$ . Refresh addresses are automatically specified by the on-chip address counter, and the refresh period is determined by the on-chip timer.

Automatic refresh and self refresh are distinguished from each other by the width of the  $\overline{\text{OE}}/\overline{\text{RFSH}}$  low pulse in standby mode. If the  $\overline{\text{OE}}/\overline{\text{RFSH}}$  low pulse is wider than 8  $\mu\text{s}$ , RAM becomes into self refresh mode; if the  $\overline{\text{OE}}/\overline{\text{RFSH}}$  low pulse is less than 8  $\mu\text{s}$ , it is recognized as an automatic refresh instruction.

At the end of self refresh, refresh reset time ( $t_{\text{RFS}}$ ) is required to reset the internal self refresh operation of the RAM. During  $t_{\text{RFS}}$ ,  $\overline{\text{CE}}$  and  $\overline{\text{OE}}/\overline{\text{RFSH}}$  must be kept high. If auto refresh follows self refresh, low transition of  $\overline{\text{OE}}/\overline{\text{RFSH}}$  at the beginning of automatic refresh must not occur during  $t_{\text{RFS}}$  period.

#### Others

Since pseudo static RAM consists of dynamic circuits like DRAM, its clock pins are more noise-sensitive than conventional SRAM's.

- (1) If a short  $\overline{\text{CE}}$  pulse of a width less than  $t_{\text{CE min}}$  is applied to RAM, an incomplete read occurs and stored data may be destroyed. Make sure that  $\overline{\text{CE}}$  low pulses of less than  $t_{\text{CE min}}$  are inhibited. Note that a 10 ns  $\overline{\text{CE}}$  low pulse may sometimes occur owing to the gate delay on the board if the  $\overline{\text{CE}}$  signal is generated by the decoding of higher address signals on the board. Avoid these short pulses.
- (2)  $\overline{\text{OE}}/\overline{\text{RFSH}}$  works as refresh control in standby mode. A short  $\overline{\text{OE}}/\overline{\text{RFSH}}$  low pulse may cause an incomplete refresh that will destroy data. Make sure that  $\overline{\text{OE}}/\overline{\text{RFSH}}$  low pulse of less than  $t_{\text{FAP min}}$  are also inhibited.
- (3)  $t_{\text{OHC}}$  and  $t_{\text{OCD}}$  are the timing specs which distinguish the  $\overline{\text{OE}}$  function of  $\overline{\text{OE}}/\overline{\text{RFSH}}$  from the  $\overline{\text{RFSH}}$  function. The  $t_{\text{OHC}}$  and  $t_{\text{OCD}}$  specs must be strictly maintained.
- (4) Start the HM658512AI operating by executing at least eight initial cycles (dummy cycles) at least 100  $\mu\text{s}$  after the power voltage reaches 4.5 V to 5.5 V after power-on.

## HM658512AI Series

### Operation Table

$\overline{CE}$	$\overline{OE/RFSH}$	$\overline{WE}$	I/O	Operation
L	L	H	Dout	Read
L	×	L	High-Z	Write
L	H	H	High-Z	—
H	L	×	High-Z	Refresh
H	H	×	High-Z	Standby

Note: H;  $V_{IH}$ , L;  $V_{IL}$ , ×;  $V_{IH}$  or  $V_{IL}$

### Absolute Maximum Ratings

Parameter	Symbol	Value	Unit	Note
Terminal voltage with respect to $V_{SS}$	$V_T$	-1.0 to +7.0	V	1
Power dissipation	$P_T$	1.0	W	
Storage temperature range	Tstg	-55 to +125	°C	
Storage temperature range under bias	Tbias	-40 to +85	°C	

Note: 1. With respect to  $V_{SS}$

### DC Operating Conditions

Parameter	Symbol	Min	Typ	Max	Unit	Notes
Supply voltage	$V_{CC}$	4.5	5.0	5.5	V	
	$V_{SS}$	0	0	0	V	
Input high voltage	$V_{IH}$	2.8	—	6.0	V	
Input low voltage	$V_{IL}$	-1.0	—	0.8	V	1
Ambient temperature range	Ta	-40	—	+85	°C	

Note: 1.  $V_{IL}$  min = -3.0 V for pulse width 30 ns

## HM658512AI Series

### DC Characteristics

Parameter	Symbol	Min	Typ	Max	Unit	Test conditions	Notes
Operating power supply current	$I_{CC1}$	—	—	75	mA	$I_{VO} = 0 \text{ mA}$ , $t_{cyc} = \text{min}$	
Standby power supply current	$I_{SB1}$	—	1	2	mA	$\overline{CE} = V_{IH}$ , $V_{in} \geq 0 \text{ V}$ $\overline{OE}/\overline{RFSH} = V_{IH}$	
	$I_{SB2}$	—	20	200	$\mu\text{A}$	$\overline{CE} \geq V_{CC} - 0.2 \text{ V}$ , $V_{in} \geq 0 \text{ V}$ , $\overline{OE}/\overline{RFSH} \geq V_{CC} - 0.2 \text{ V}$	
Operating power supply current in self refresh mode	$I_{CC2}$	—	1	2	mA	$\overline{CE} = V_{IH}$ , $V_{in} \geq 0 \text{ V}$ , $\overline{OE}/\overline{RFSH} = V_{IL}$	
	$I_{CC3}$	—	70	200	$\mu\text{A}$	$\overline{CE} \geq V_{CC} - 0.2 \text{ V}$ , $V_{in} \geq 0 \text{ V}$ , $\overline{OE}/\overline{RFSH} \leq 0.2 \text{ V}$	
Input leakage current	$I_{LI}$	-10	—	10	$\mu\text{A}$	$V_{CC} = 5.5 \text{ V}$ , $V_{in} = V_{SS} \text{ to } V_{CC}$	
Output leakage current	$I_{LO}$	-10	—	10	$\mu\text{A}$	$\overline{OE}/\overline{RFSH} = V_{IH}$ $V_{VO} = V_{SS} \text{ to } V_{CC}$	
Output voltage	$V_{OL}$	—	—	0.4	V	$I_{OL} = 2.1 \text{ mA}$	
	$V_{OH}$	2.4	—	—	V	$I_{OH} = -1 \text{ mA}$	

### Capacitance ( $T_a = 25^\circ\text{C}$ , $f = 1 \text{ MHz}$ )

Parameter	Symbol	Typ	Max	Unit	Test conditions
Input capacitance	$C_{in}$	—	8	pF	$V_{in} = 0 \text{ V}$
Input/output capacitance	$C_{VO}$	—	10	pF	$V_{VO} = 0 \text{ V}$

Note : This parameter is sampled and not 100% tested.

### AC Characteristics ( $T_a = -40 \text{ to } +85^\circ\text{C}$ , $V_{CC} = 5 \text{ V} \pm 10\%$ , unless otherwise noted.)

#### Test Conditions

- Input pulse levels: 0.4 V, 2.8 V
- Input rise and fall time: 5 ns
- Timing measurement level: 0.8 V, 2.2 V
- Reference levels:  $V_{OH} = 2.0 \text{ V}$ ,  $V_{OL} = 0.8 \text{ V}$
- Output load: 1 TTL Gate and  $C_L$  (100 pF) (Including scope and jig)

## HM658512AI Series

		HM658512AI							
		-8		-10		-12			
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Unit	Notes
Random read or write cycle time	$t_{RC}$	130	—	160	—	190	—	ns	
Chip enable access time	$t_{CEA}$	—	80	—	100	—	120	ns	
Read-modify- write cycle time	$t_{RWC}$	180	—	220	—	260	—	ns	
Output enable access time	$t_{OEA}$	—	30	—	40	—	50	ns	
Chip disable to output in high-Z	$t_{CHZ}$	0	25	0	25	0	30	ns	1, 2
Chip enable to output in low-Z	$t_{CLZ}$	20	—	20	—	20	—	ns	2
Output disable to output in high-Z	$t_{OHZ}$	—	25	—	25	—	25	ns	1, 2
Output enable to output in low-Z	$t_{OLZ}$	0	—	0	—	0	—	ns	2
Chip enable pulse width	$t_{CE}$	80 n	10 $\mu$	100 n	10 $\mu$	120 n	10 $\mu$	s	
Chip enable precharge time	$t_p$	40	—	50	—	60	—	ns	
Address setup time	$t_{AS}$	0	—	0	—	0	—	ns	
Address hold time	$t_{AH}$	20	—	25	—	30	—	ns	
Read command setup time	$t_{RCS}$	0	—	0	—	0	—	ns	
Read command hold time	$t_{RCH}$	0	—	0	—	0	—	ns	
Write command pulse width	$t_{WP}$	25	—	30	—	35	—	ns	
Chip enable to end of write	$t_{CW}$	80	—	100	—	120	—	ns	
Chip enable to output enable delay time	$t_{OCD}$	0	—	0	—	0	—	ns	
Output enable hold time	$t_{OHC}$	0	—	0	—	0	—	ns	
Data in to end of write	$t_{DW}$	20	—	25	—	30	—	ns	
Data in hold time for write	$t_{DH}$	0	—	0	—	0	—	ns	
Output active from end of write	$t_{OW}$	5	—	5	—	5	—	ns	2
Write to output in high-Z	$t_{WHZ}$	—	20	—	25	—	30	ns	1, 2
Transition time (rise and fall)	$t_T$	3	50	3	50	3	50	ns	6

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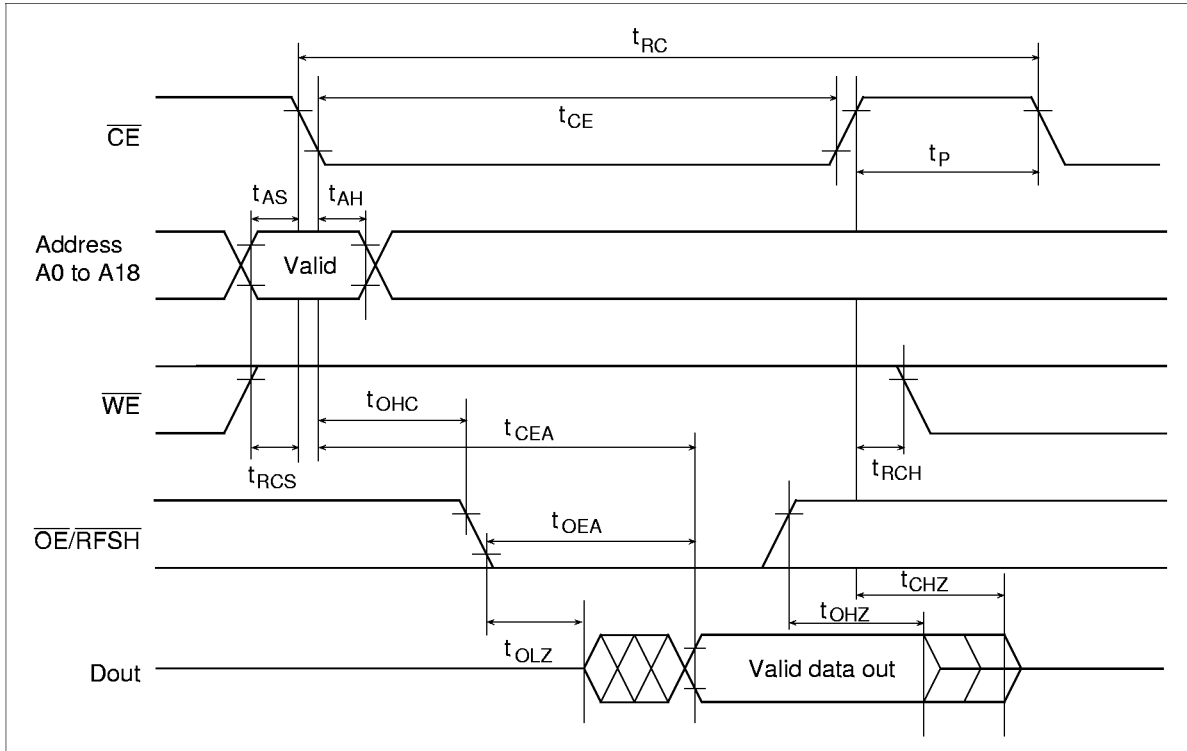
Parameter	Symbol	HM658512AI						Unit	Notes
		-8		-10		-12			
		Min	Max	Min	Max	Min	Max		
Refresh command delay time	$t_{\text{RFD}}$	40	—	50	—	60	—	ns	
Refresh precharge time	$t_{\text{FP}}$	40	—	40	—	40	—	ns	
Refresh command pulse width for automatic refresh	$t_{\text{FAP}}$	80 n	8 $\mu$	80 n	8 $\mu$	80 n	8 $\mu$	s	
Automatic refresh cycle time	$t_{\text{FC}}$	130	—	160	—	190	—	ns	
Refresh command pulse width for self refresh	$t_{\text{FAS}}$	8	—	8	—	8	—	$\mu$ s	
Refresh reset time from self refresh	$t_{\text{RFS}}$	600	—	600	—	600	—	ns	9
Refresh period	$t_{\text{REF}}$	—	32	—	32	—	32	ms	2048 cycle

- Notes:
- $t_{\text{CHZ}}$ ,  $t_{\text{OHZ}}$ ,  $t_{\text{WHZ}}$  are defined as the time at which the output achieves the open circuit condition.
  - $t_{\text{CHZ}}$ ,  $t_{\text{GLZ}}$ ,  $t_{\text{OHZ}}$ ,  $t_{\text{OLZ}}$ ,  $t_{\text{WHZ}}$  and  $t_{\text{OW}}$  are sampled under the condition of  $t_{\text{r}} = 5$  ns and not 100% tested.
  - A write occurs during the overlap of low  $\overline{\text{CE}}$  and low  $\overline{\text{WE}}$ . Write end is defined at the earlier of  $\overline{\text{WE}}$  going high or  $\overline{\text{CE}}$  going high.
  - If the  $\overline{\text{CE}}$  low transition occurs simultaneously with or from the  $\overline{\text{WE}}$  low transition, the output buffers remain in high impedance state.
  - In write cycle,  $\overline{\text{OE}}$  or  $\overline{\text{WE}}$  must disable output buffers prior to applying data to the device and at the end of write cycle data inputs must be floated prior to  $\overline{\text{OE}}$  or  $\overline{\text{WE}}$  turning on output buffers. During this period, I/O pins are in the output state, therefore the input signals of opposite phase to the outputs must not be applied.
  - Transition time  $t_{\text{r}}$  is measured between  $V_{\text{IH}}$  (min) and  $V_{\text{IL}}$  (max).  $V_{\text{IH}}$  (min) and  $V_{\text{IL}}$  (max) are reference levels for measuring timing of input signals.
  - After power-up, pause for more than 100  $\mu$ s and execute at least 8 initialization cycles.
  - 2048 cycles of burst refresh or the first cycle of distributed automatic refresh must be executed within 15  $\mu$ s after self refresh, in order to meet the refresh specification of 32 ms and 2048 cycles.
  - At the end of self refresh, refresh reset time ( $t_{\text{RFS}}$ ) is required to reset the internal self refresh operation of the RAM. During  $t_{\text{RFS}}$ ,  $\overline{\text{CE}}$  and  $\overline{\text{OE/RFSH}}$  must be kept high. If automatic refresh follows self refresh, low transition of  $\overline{\text{OE/RFSH}}$  at the beginning of automatic refresh must not occur during  $t_{\text{RFS}}$  period.



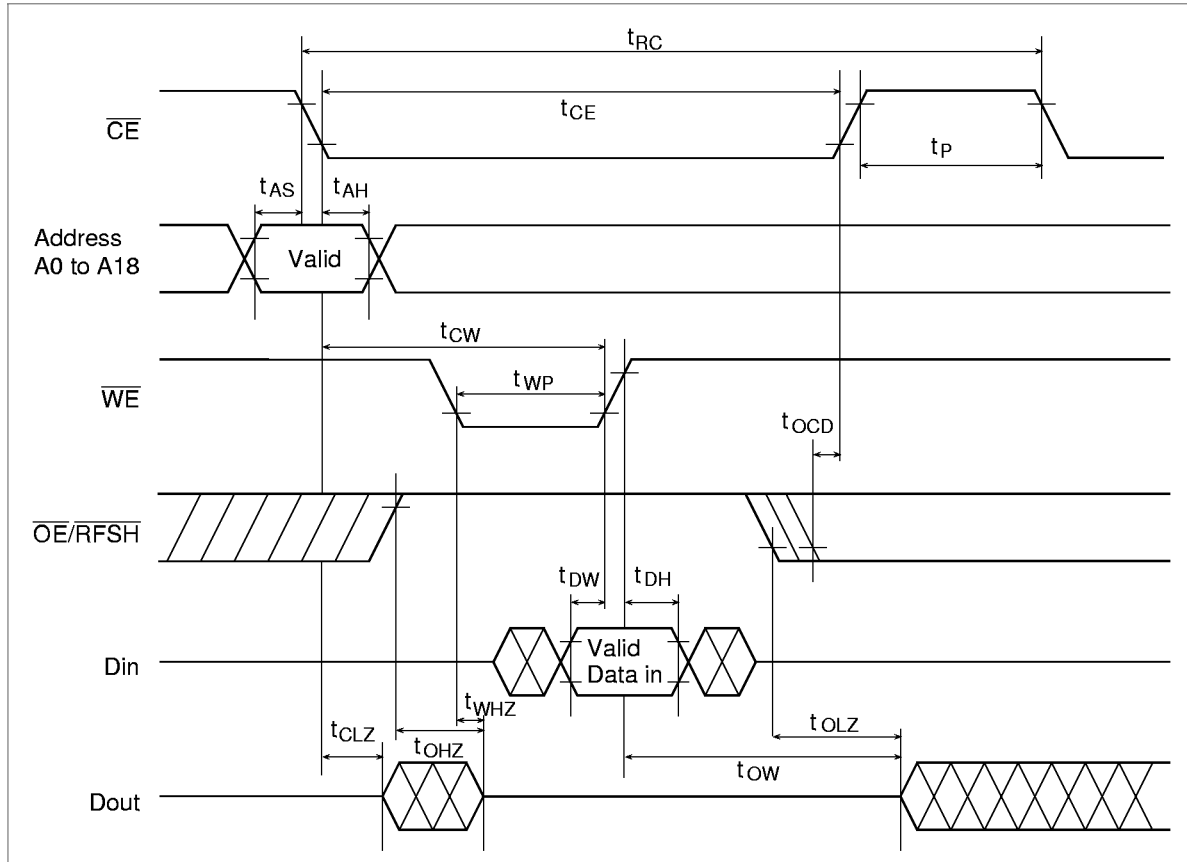
Timing Waveform

Read Cycle

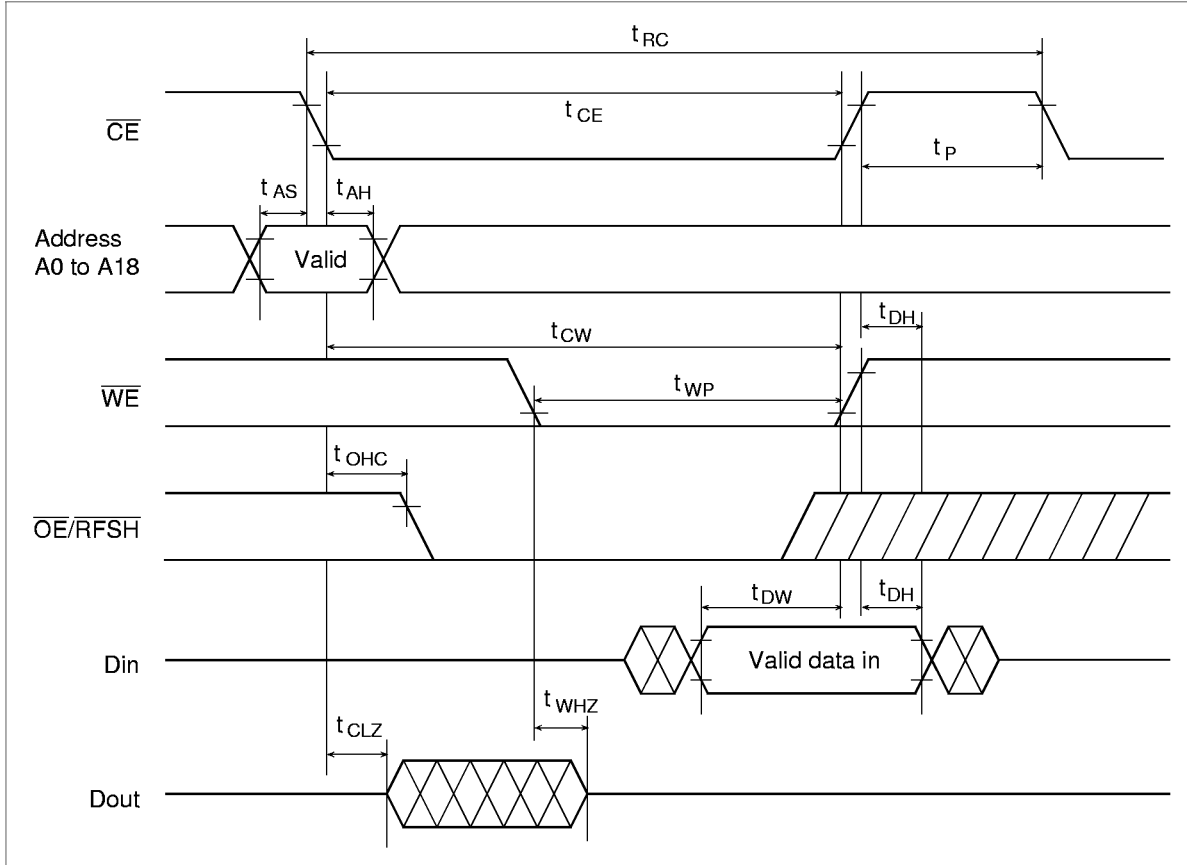


## HM658512AI Series

### Write Cycle (1) ( $\overline{OE} = V_{IH}$ )

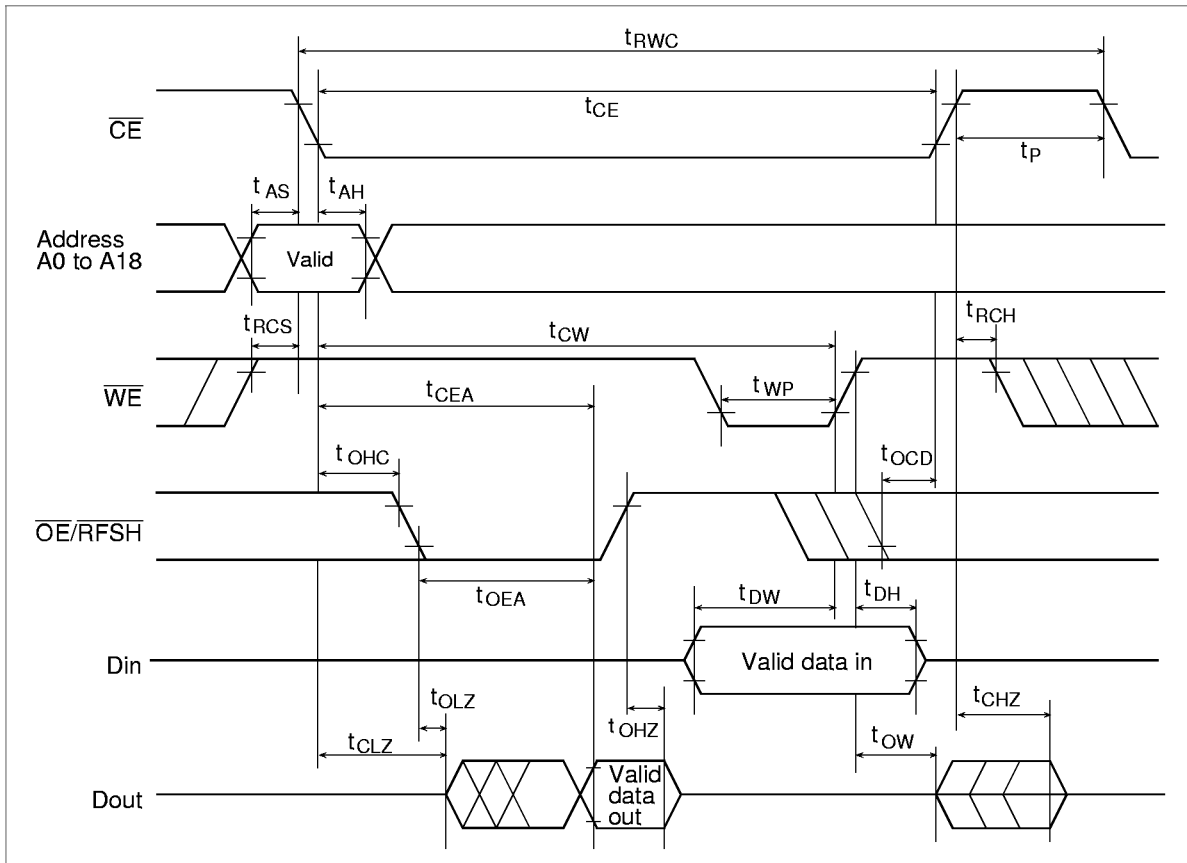


Write Cycle (2) ( $\overline{OE} = V_{IL}$ )

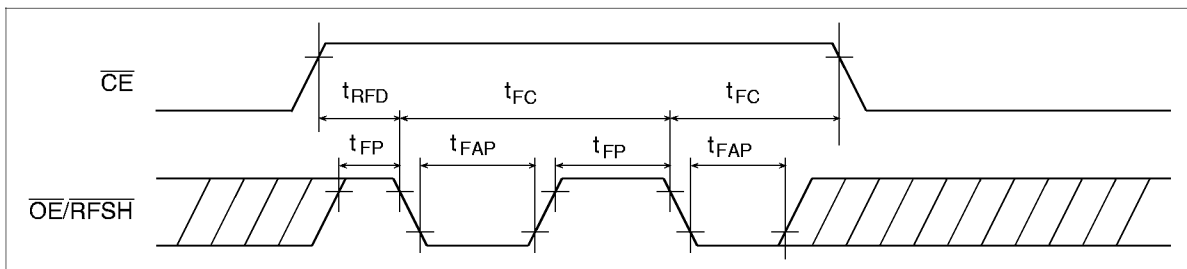


# HM658512AI Series

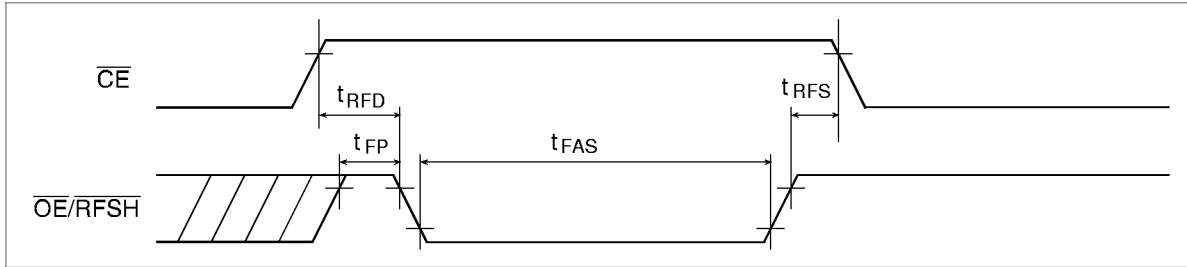
## Read-Modify-Write Cycle



## Automatic Refresh Cycle



Self Refresh Cycle



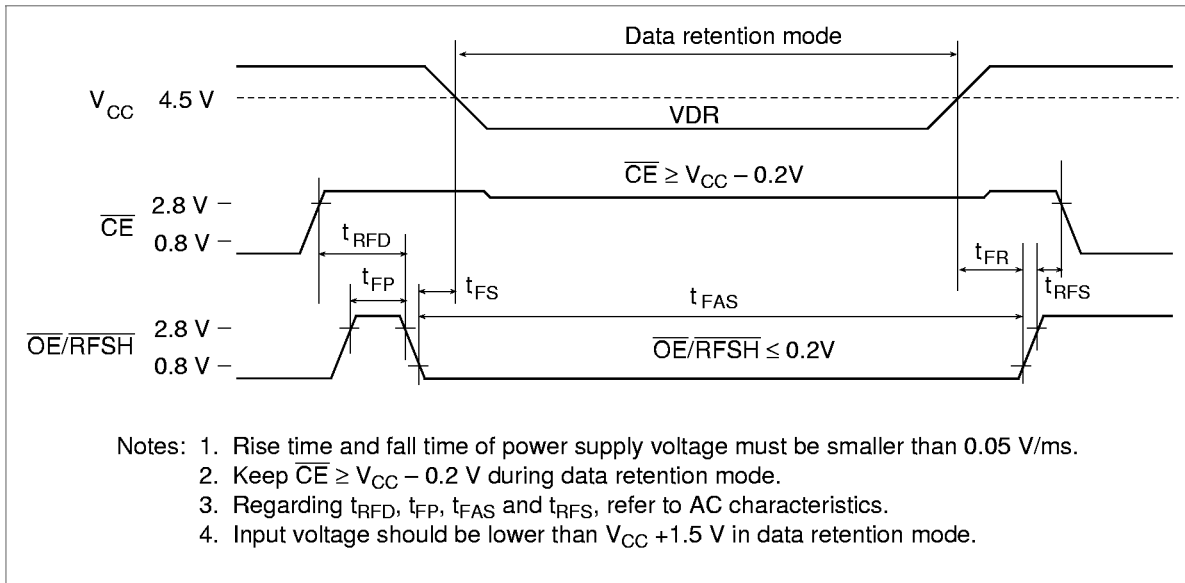
Low  $V_{CC}$  Data Retention Characteristics ( $T_a = -40$  to  $+85^\circ\text{C}$ )

This characteristics is guaranteed only for V-version.

Parameter	Symbol	Min	Typ	Max	Unit	Test conditions
$V_{CC}$ for data retention	$V_{DR}$	3.6	—	5.5	V	
Self refresh current	$I_{CCDR}$	—	—	200	$\mu\text{A}$	$V_{CC} = 3.6\text{ V}$ , $\overline{CE} \geq V_{CC} - 0.2\text{ V}$ $\overline{OE/RFSH} \leq 0.2$ $V_{in} \geq 0\text{ V}$
		—	—	200	$\mu\text{A}$	$V_{CC} = 5.5\text{ V}$ , $\overline{CE} \geq V_{CC} - 0.2\text{ V}$ $\overline{OE/RFSH} \leq 0.2$ $V_{in} \geq 0\text{ V}$
Refresh setup time	$t_{FS}$	0	—	—	ns	
Operation recovery time	$t_{FR}$	5	—	—	ms	

## HM658512AI Series

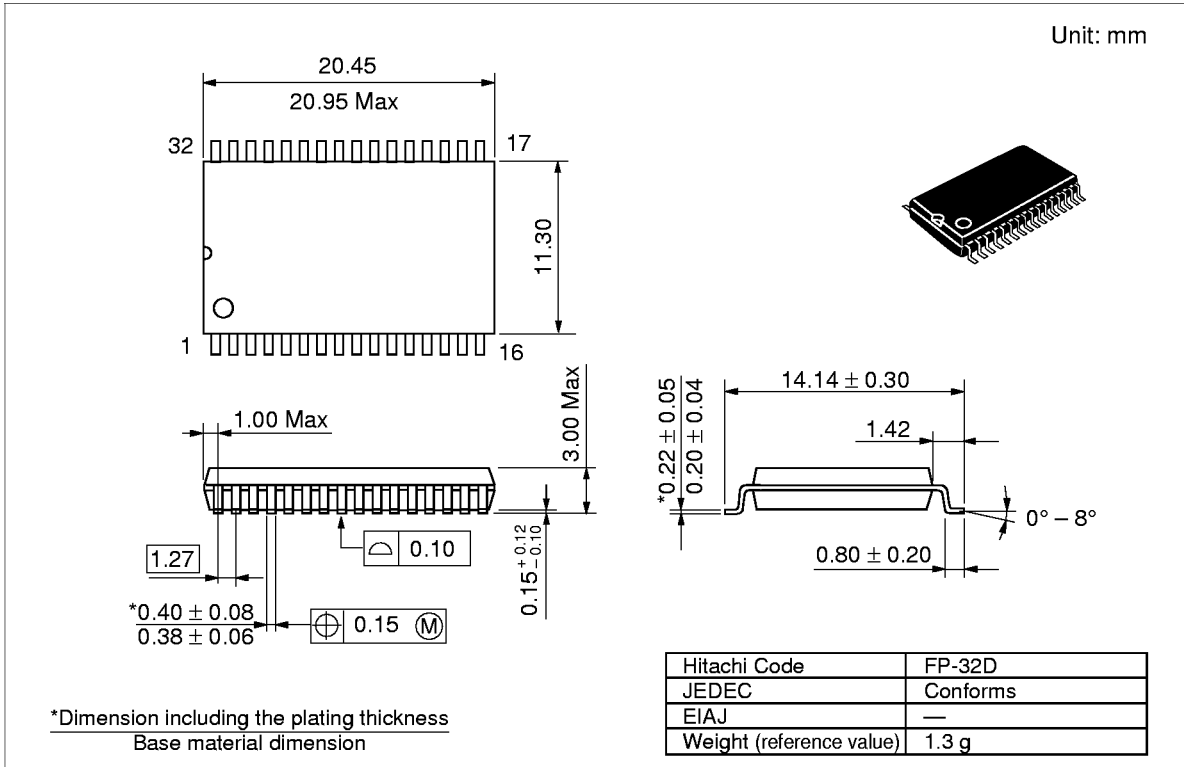
### Low $V_{CC}$ Data Retention Timing Waveform



# HM658512AI Series

## Package Dimensions

### HM658512ALFPI Series (FP-32D)



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## HM658512AI Series

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## Revision Record

Rev.	Date	Contents of Modification	Drawn by	Approved by
0.0	Jul. 15, 1994	Initial issue	H. Uchida	M. Watanabe
1	Nov. 3, 1994	Deletion of preliminary	K. Imato	K. Yoshizaki
2.0	Apr. 20, 1995	Addition of HM658512 AFPI-8 Series	K. Imato	K. Yoshizaki

### AC Characteristics

$t_{RC}$  min: 160/190 ns to 130/160/190 ns  
 $t_{CEA}$  max: 100/120 ns to 80/100/120 ns  
 $t_{RWC}$  min: 220/260 ns to 180/220/260 ns  
 $t_{OEA}$  max: 40/50 ns to 30/40/50 ns  
 $t_{CHZ}$  min: 0/0 ns to 0/0/0 ns  
 $t_{CHZ}$  max: 25/30 ns to 25/25/30 ns  
 $t_{CLZ}$  min: 20/20 ns to 20/20/20 ns  
 $t_{OHZ}$  max: 25/25 ns to 25/25/25 ns  
 $t_{OLZ}$  min: 0/0 ns to 0/0/0 ns  
 $t_{CE}$  min: 100/120 ns to 80/100/120 ns  
 $t_{CE}$  max: 10000/10000 ns to 10000/10000/10000 ns  
 $t_p$  min: 50/60 ns to 40/50/60 ns  
 $t_{AS}$  min: 0/0 ns to 0/0/0 ns  
 $t_{AH}$  min: 25/30 ns to 25/25/30 ns  
 $t_{RCS}$  min: 0/0 ns to 0/0/0 ns  
 $t_{RCH}$  min: 0/0 ns to 0/0/0 ns  
 $t_{WP}$  min: 30/35 ns to 25/30/35 ns  
 $t_{CW}$  min: 100/120 ns to 80/100/120 ns  
 $t_{OCD}$  min: 0/0 ns to 0/0/0 ns  
 $t_{OHC}$  min: 0/0 ns to 0/0/0 ns  
 $t_{DW}$  min: 25/30 ns to 25/25/30 ns  
 $t_{DH}$  min: 0/0 ns to 0/0/0 ns  
 $t_{OW}$  min: 5/5 ns to 5/5/5 ns

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## HM658512AI Series

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$t_{WHZ}$  max: 25/30 ns to 25/25/30 ns  
 $t_T$  min: 3/3 ns to 3/3/3 ns  
 $t_T$  max: 50/50 ns to 50/50/50 ns  
 $t_{RFD}$  min: 50/60 ns to 40/50/60 ns  
 $t_{FP}$  min: 40/40 ns to 40/40/40 ns  
 $t_{FAP}$  min: 80/80 ns to 80/80/80 ns  
 $t_{FAP}$  max: 8000/8000 ns to 8000/8000/8000 ns  
 $t_{FC}$  min: 160/190 ns to 130/160/190 ns  
 $t_{FAS}$  min: 8/8  $\mu$ s to 8/8/8  $\mu$ s  
 $t_{RFS}$  min: 600/600 ns to 600/600/600 ns  
 $t_{REF}$  max: 32/32 ms to 32/32/32 ms

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### Revision Record (cont.)

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Rev.	Date	Contents of Modification	Drawn by	Approved by
3.0	Mar. 15, 1999	Change data sheet title HM658128AFPI Series to HM658512AI Series Change format Description Deletion of description about temperature range Features Addition of temperature range: $-40$ to $+85^{\circ}\text{C}$ Deletion of HM658512ADFPI Series DC Characteristics Deletion of note 1 AC Characteristics Deletion of note 10 Correct error of Low $V_{CC}$ data retention timing waveform: 2.4 V to 2.8 V		

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